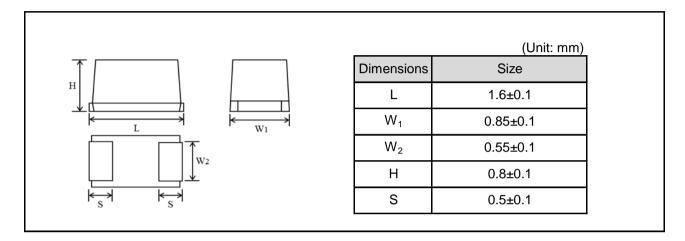
Chip tantalum capacitors (Bottom surface electrode type : Large capacitance)

TC series M case Datasheet

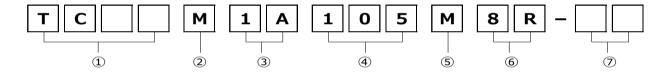
Features

- 1) Bottom electrode configuration results in significantly greater compactness.
- 2) Filet formation enables easy visibility after mounting.
- 3) Ideal for noise removal on power supply lines with limited space.
- 4) Eco-friendly halogen-free products.

Dimensions



Part No. Explanation



① Series name

TC

② Case style

M: 1608-1608(09)size

3 Rated voltage

rialed remag	<u> </u>
CODE	Rated voltage(V)
0E	2.5
0G	4
0J	6.3
1A	10
1C	16
1D	20
1E	25
1V	35
1H	50

4 Nominal capacitance

Nominal capacitance in pF in 3 digits:

2 significant figures followed by the figure representing the number of 0's.

(5) Capacitance tolerance

M: ±20%

6 Taping

8: Tape width

R: Positive electrode on the side opposite to sprocket hole

7 Discrimination code

Rated table

Impedance(Ω)

	-									dance(22)
Capa	citance	Rated voltage (V.DC)								
()	ıF)	2.5	4	6.3	10	16	20	25	35	50
1.0	(105)					15		10		
2.2	(225)				13.5	13.5				
3.3	(335)									
4.7	(475)			9	9					
6.8	(685)									
10	(106)			9	9					
15	(156)									
22	(226)		9	9						
33	(336)			9						
47	(476)									
68	(686)									
100	(107)									
150	(157)									
220	(227)									

Marking

The indications listed below should be given on the surface of a capacitor.

- (1) Polarity: The polarity should be shown by bar. (on the anode side)
- (2) Rated DC voltage: A voltage code is shown as below table.
- (3) Capacitance: A capacitance code is shown as below table.

Voltago Codo	Rated DC				
Voltage Code	Voltage (V)				
е	2.5				
g	4				
j	6.3				
Α	10				
С	16				
D	20				
E	25				
V	35				
Н	50				

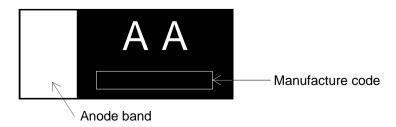
Capacitance	Nominal	Capacitance	Nominal
Code	Capacitance (µF)	Code	Capacitance (µF)
<u>E</u>	0.15	е	15
<u>N</u>	0.33	j	22
<u>S</u>	0.47	n	33
Α	1.0	S	47
Е	1.5	W	68
J	2.2	а	100
N	3.3	Φ	150
S	4.7	j	220
W	6.8	n	330
а	10	s	470

Visual typical example

voltage code and capacitance code are variable with parts number.

[TC series M case]

- (1) voltage code
- (2) capacitance code



Characteristics

Item		Performance	Test conditions (based on JIS C 5101-1 and JIS C 5101-3)					
Operating Temp	erature	-55°C~+125°C	Voltage reduction when temperature exceeds +85°C					
Maximum operate temperature with voltage derating	-	+85℃						
Rated voltage (V	'.DC)	Refer to " Standard list ".	at 85℃					
Category voltage		Refer to " Standard list ".	at 125°C					
Surge voltage (V		Refer to " Standard list ".	at 85℃					
DC Leakage cur	•	Shall be satisfied the value on	As per 4.9 JIS C 5101-1					
o		" Standard list ".	As per 4.5.1 JIS C 5101-3					
			Voltage : Rated voltage for 5min					
Capacitance tole	rance	Shall be satisfied allowance range.	As per 4.7 JIS C 5101-1					
•		±20%	As per 4.5.2 JIS C 5101-3					
			Measuring frequency :120 ± 12Hz					
			Measuring voltage :0.5Vrms + 1.5V.DC					
			Measuring circuit :DC Equivalent series circui					
Tangent of loss	angle	Shall be satisfied the value on	As per 4.8 JIS C 5101-1					
(Df,tanδ)		" Standard list ".	As per 4.5.3 JIS C 5101-3					
			Measuring frequency :120 ± 12Hz					
			Measuring voltage :0.5Vrms + 1.5V.DC					
			Measuring circuit :DC Equivalent series circui					
Impedance		Shall be satisfied the value on	As per 4.10 JIS C 5101-1					
		" Standard list ".	As per 4.5.4 JIS C 5101-3					
			Measuring frequency :100 ± 10kHz					
			Measuring voltage :0.5Vrms or less					
			Measuring circuit :DC Equivalent series circui					
Resistance to	Appe-	There should be no significant	As per 4.14 JIS C 5101-1					
Soldering	arance	abnormality.	As per 4.6 JIS C 5101-3					
heat		The indications should be clear.	Dip in the solder bath					
	L.C.	Less than 200% of initial limit.	Solder temp :240 ± 5°C					
			Duration :10 ± 0.5s					
	⊿C/C	Within ±30% of initial value.	Repetition :1					
			After the specimens, leave it at room temperature					
	DF	Less than 200% of initial limit.	for over 24h and then measure the sample.					
	(tanδ)							
Temperature	Appe-	There should be no significant	As per 4.16 JIS C 5101-1					
cycle	arance	abnormality.	As per 4.10 JIS C 5101-3					
		The indications should be clear.	Repetition: 5 cycles					
	L.C.	Less than 200% of initial limit.	(1 cycle : steps 1 to 4) without discontinuation.					
	10/0		Temp. Time					
	⊿C/C	Within ±30% of initial value.	1 -55±3°C 30±3min					
	55	Lass than 0000/ 11 W L W	2 Room Temp. 3min or less					
	DF (45)	Less than 200% of initial limit.	3 125±2℃ 30±3min					
	(tanδ)		4 Room Temp. 3min or less					
			After the specimens, leave it at room temperature					
			for over 24h and then measure the sample.					
			Initial value for ∠C/C shall be the value after					
			mounted.					

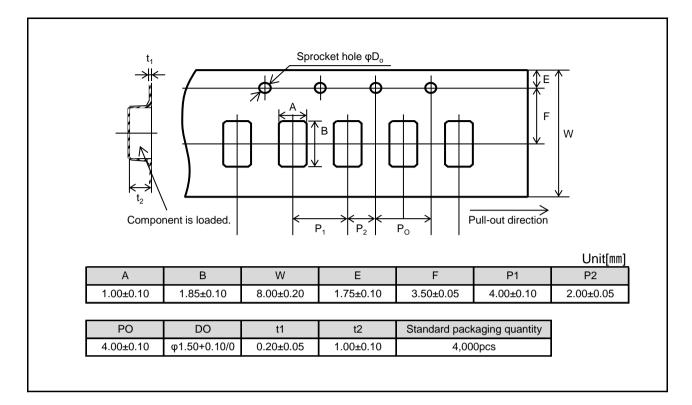
Item		Performance	Test conditions (based on JIS C 5101-1 and JIS C 5101-3)						
Moisture	Appe-	There should be no significant	As per 4.22 JIS C 5101-1						
resistance	arance	abnormality.	As per 4.12 JIS C 5101-3						
10313141100	ararioo	The indications should be clear.	After leaving the sample under such atmospheric						
	L.C.	Less than 200% of initial limit.	condition that the temperature and humidity are						
	L.O.	Less than 20070 of finital liftit.	60±2°C and 90 to 95% RH, respectively, for						
	⊿C/C	Within ±30% of initial value.	500+12/0h leave it at room temperature for						
	20/0	VVIIIII ±30 /0 01 IIIIIIII VIIIIC.	over 24h and then measure the sample.						
	DF	Less than 200% of initial limit.	Initial value for ∠C/C shall be the value after						
	(tanδ)	Less than 20070 of finital liftit.	mounted.						
Temperature	Temp.:-	<u>I</u> 55°C	As per 4.29 JIS C 5101-1						
Stability	⊿C/C	Within 0/-30% of initial value.	As per 4.13 JIS C 5101-3						
Stability	20/0	Within 0/-30 % of finitial value.	Initial value for △C/C shall be the value after						
	DF	Shall be satisfied the value on	mounted.						
		" Standard list "	mounted.						
	(tanδ) L.C.		\dashv						
	L.C.	<u> </u>							
	Temp.:	I	\dashv						
	⊿C/C	Within +15/-5% of initial value.	\dashv						
	20/0	Within T10/-0 /0 Of Illitial Value.							
	DF	Shall be satisfied the value on	\dashv						
	(tanδ)	" Standard list "							
	L.C.	Less than 1000% of initial limit.	\dashv						
	L.O.	Less than 1000% of initial limit.							
	Temp.:	125°C	\dashv						
	⊿C/C	Within +20/-5% of initial value.	- 						
	20/0	Within +20/-3 /6 of finitial value.							
	DF	Shall be satisfied the value on							
	(tanδ)	" Standard list "							
	L.C.	Less than 1250% of initial limit.	\dashv						
	2.0.	2000 11011 120070 01 1111101 111111							
Surge	Appe-	There should be no significant	As per 4.26JIS C 5101-1						
voltage	arance	abnormality.	As per 4.14JIS C 5101-3						
5	1	•	•						
		The indications should be clear.	Apply the specified surge voltage via the serial						
	L.C.	Less than 200% of initial limit.	Apply the specified surge voltage via the serial resistance of 1kΩ ever 5±0.5 min. for 30±5 s.						
	L.C.		resistance of 1kΩ ever 5±0.5 min. for 30±5 s.						
	L.C. ⊿C/C		resistance of $1k\Omega$ ever 5 ± 0.5 min. for 30 ± 5 s. each time in the atmospheric condition of						
		Less than 200% of initial limit.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times.						
		Less than 200% of initial limit.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature						
	⊿C/C	Less than 200% of initial limit. Within ±20% of initial value.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample.						
	⊿C/C	Less than 200% of initial limit. Within ±20% of initial value.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature						
Loading at	⊿C/C DF (tanδ)	Less than 200% of initial limit. Within ±20% of initial value.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted.						
	⊿C/C	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted. As per 4.23 JIS C 5101-1						
High	⊿C/C DF (tanδ)	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3						
High	⊿C/C DF (tanδ) Appearance	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality. The indications should be clear.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 1000+36/0 h						
High	⊿C/C DF (tanδ)	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 1000+36/0 h without discontinuation via the serial resistance						
High	⊿C/C DF (tanδ) Appearance L.C.	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality. The indications should be clear. Less than 200% of initial limit.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ⊿C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 1000+36/0 h without discontinuation via the serial resistance of 3Ω or less at a temperature of 85±2°C, leave						
High	⊿C/C DF (tanδ) Appearance	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality. The indications should be clear.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ∠C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 1000+36/0 h without discontinuation via the serial resistance of 3Ω or less at a temperature of 85±2°C, leave the sample at room temperature / humidity for						
Loading at High temperature	⊿C/C DF (tanδ) Appearance L.C.	Less than 200% of initial limit. Within ±20% of initial value. Less than 200% of initial limit. There should be no significant abnormality. The indications should be clear. Less than 200% of initial limit.	resistance of 1kΩ ever 5±0.5 min. for 30±5 s. each time in the atmospheric condition of 85±2°C. Repeat this procedure 1,000 times. After the specimens, leave it at room temperature for over 24h and then measure the sample. Initial value for ⊿C/C shall be the value after mounted. As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 1000+36/0 h without discontinuation via the serial resistance of 3Ω or less at a temperature of 85±2°C, leave						

Item		Performance	Test conditions (based on JIS C 5101-1 and JIS C 5101-3)			
Tamainal	Cono	The recovered value should be	·			
Terminal	Capa- citance	The measured value should be stable.	As per 4.35 JIS C 5101-1			
strength			As per 4.9 JIS C 5101-3			
	Appe-	There should be no significant	A force is applied to the terminal until it bends to			
	arance	abnormality.	1mm and by a prescribed tool maintains the			
			condition for 5s.			
			(See the figure below)			
			F(Apply force) R230 Thickness=1.6mm			
A dhaair ranaaa		The terminal should not some off	As not 4.24 IIS C 54.04.4			
Adhesiveness		The terminal should not come off.	As per 4.34 JIS C 5101-1			
			As per 4.8 JIS C 5101-3			
			Apply force of 2N in the two directions shown in			
			the figure below for 10±1s after mounting the			
			terminal on a circuit board.			
			Apply force A circuit board			
Dimensions		Refer to "External dimensions".	Measure using a caliper of JIS B 7507 Class			
			2 or higher grade.			
Resistance to		The indication should be clear.	As per 4.32 JIS C 5101-1			
solvents			As per 4.18 JIS C 5101-3			
			Dip in the isopropyl alcohol for 30±5s, at room			
			temperature.			
Solderability		3/4 or more surface area of the	As per 4.15.2 JIS C 5101-1			
		solder coated terminal dipped in	As per 4.7 JIS C 5101-3			
		the soldering bath should be	Dip speed=25±2.5mm/s			
		covered with the new solder.	Pre-treatment (accelerated aging):			
			Leave the sample on the boiling distilled water			
			for 1h.			
			Solder temp. : 245±5°C			
			Duration : 3±0.5s			
			Solder : M705			
			Flux : Rosin 25% IPA 75%			
	Capa-	Measure value should not fluctuate	As per 4.17 JIS C 5101-1			
Vibration			1 -			
Vibration	citance	during the measurement.	Frequency: 10 to 55 to 10Hz/min.			
Vibration	citance	during the measurement. There should be no significant	Frequency: 10 to 55 to 10Hz/min. Amplitude: 1.5mm			
Vibration		There should be no significant	Amplitude : 1.5mm			
Vibration	citance Appe-					

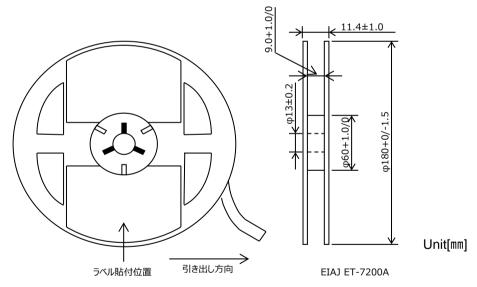
● Standard products list

	Rated	Category	Surge	Cap.	Tole-	Leakage		tanδ		Impedance
	voltage	voltage	voltage		rance	current	120Hz			
	85°C	105℃	85°C	120Hz		25℃				100kHz
Part No.						1WV	-55℃	25℃	105℃	
						5min				
	(V)	(V)	(V)	(μF)	(%)	(µA)	(%)	(%)	(%)	(Ω)
TCM0G226M8R	4	2.5	5	22	±20	0.9	30	20	30	9
TCM0J475M8R	6.3	4	8	4.7	±20	0.5	30	20	30	9
TCM0J106M8R	6.3	4	8	10	±20	0.6	30	20	30	9
TCM0J226M8R-V1	6.3	4	8	22	±20	13.0	60	30	40	9
TCM0J336M8R-V1	6.3	4	8	33	±20	208.0	60	30	40	9
TCM1A225M8R	10	6.3	13	2.2	±20	0.5	30	20	30	13.5
TCM1A475M8R	10	6.3	13	4.7	±20	0.5	30	20	30	9
TCM1A106M8R	10	6.3	13	10	±20	10.0	30	20	30	9
TCM1C105M8R	16	10	20	1	±20	0.5	15	10	15	15
TCM1C225M8R	16	10	20	2.2	±20	0.5	30	20	30	13.5
TCM1E105M8R	25	16	32	1	±20	0.5	15	10	15	10

Packaging specifications



Reel dimensions



Notes

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